


Issue Classification 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/717,243		BETTER ET AL.	
	Examiner		Art Unit	
	Phuong Huynh		1644	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
530		326			530	350	387.3	866	
INTERNATIONAL CLASSIFICATION									
C	0	7	K	16/00					
A	6	1	K	38/16					
A	6	1	K	38/10					
C	1	2	P	21/08					
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Phuong Huynh 7/21/06 (Assistant Examiner) (Date)		Christina Chan CHRISTINA CHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 1600 7/21/06		Total Claims Allowed: 11 O.G. Print Claim(s) 1 O.G. Print Fig. None	
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<input type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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